Application/Control No. Applicant(s)/Patent Under Reexamination 10/604,689 CHANG ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 William Boddie 2629 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 345/173 US-6,965,377 11-2005 Yanagisawa et al. Α US-В US-C US-D US-E US-US-G US-Н US-US-US-K US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY N 0 P Q R S T **NON-PATENT DOCUMENTS** * Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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